Notice of References Cited	Application/Control No. 10/589,240	Applicant(s)/Patent Under Reexamination YAMAGUCHI ET AL.		
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U.S. PATENT DOCUMENTS				

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2006/0244624	11-2006	Wang et al.	340/815.67
	В	US-			
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FOREIGN PATENT DOCUMENTS

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